TOSHIBA Field Effect Transistor Silicon N Channel MOS Type

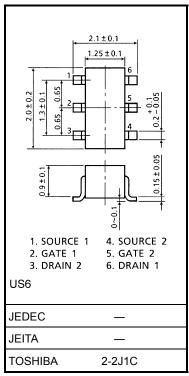
# HN1K05FU

For Portable Devices High Speed Switching Applications Interface Applications

- High input impedance and extremely low drive current.
- + Vth is low and it is possible to drive directly at low-voltage CMOS. : Vth = 0.5 to 1.0 V
- Suitable for high-density mounting because of a compact package.

#### Absolute Maximum Ratings (Ta = 25°C) (Q1, Q2 common)

Characteristics	Symbol	Rating	Unit
Drain-source voltage	V <sub>DS</sub>	20	V
Gate-source voltage	V <sub>GSS</sub>	10	V
DC drain current	۱ <sub>D</sub>	100	mA
Drain power dissipation	P <sub>D</sub> (Note 1)	200	mW
Channel temperature	T <sub>ch</sub>	150	°C
Storage temperature range	T <sub>stg</sub>	–55 to 150	°C



Weight: 6.8 mg

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

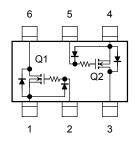
Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: TOTAL rating

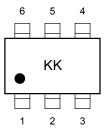
## Electrical Characteristics (Ta = 25°C) (Q1, Q2 common)

Characteristic	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current	I <sub>GSS</sub>	$V_{GS} = 10 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			1	μA
Drain-source breakdown voltage	V (BR) DSS	$I_D = 100 \ \mu A, \ V_{GS} = 0 \ V$	20		_	V
Drain cut-off current	I <sub>DSS</sub>	$V_{DS} = 20 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$	_		1	μA
Gate threshold voltage	V <sub>th</sub>	$V_{DS} = 1.5 \text{ V}, I_D = 0.1 \text{ mA}$	0.5	_	1	V
Forward transfer admittance	Y <sub>fs</sub>	$V_{DS} = 1.5 \text{ V}, \text{ I}_{D} = 10 \text{ mA}$	35	70	_	mS
Drain-Source ON resistance 1	R <sub>DS (ON)</sub> 1	$I_D=1\ mA,\ V_{GS}=1.2\ V$	_	15	50	Ω
Drain-Source ON resistance 2	R <sub>DS (ON) 2</sub>	$I_D = 10 \text{ mA}, V_{GS} = 1.5 \text{ V}$	_	10	40	Ω
Drain-Source ON resistance 3	R <sub>DS (ON) 3</sub>	$I_D = 10 \text{ mA}, V_{GS} = 2.5 \text{ V}$	_	7	28	Ω
Input capacitance	C <sub>iss</sub>	$V_{DS}$ = 1.5 V, $V_{GS}$ = 0 V, f = 1 MHz	_	12	_	pF
Reverse transfer capacitance	C <sub>rss</sub>	$V_{DS}$ = 1.5 V, $V_{GS}$ = 0 V, f = 1 MHz	_	3.4	_	pF
Output capacitance	C <sub>oss</sub>	$V_{DS}$ = 1.5 V, $V_{GS}$ = 0 V, f = 1 MHz	_	12	_	pF
Switching time	t <sub>on</sub>		_	0.35	_	μS
	t <sub>off</sub>	$V_{DD} = 1.5 \text{ V}, \text{ I}_{D} = 10 \text{ mA}, V_{GS} = 0 \text{ to } 1.5 \text{ V}$	_	0.2	_	

# Equivalent Circuit (top view)



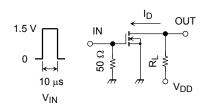
# Marking



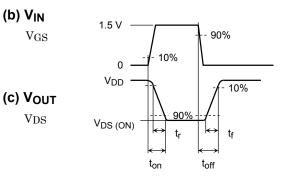
(Q1, Q2 common)

# Switching Time Test Circuit

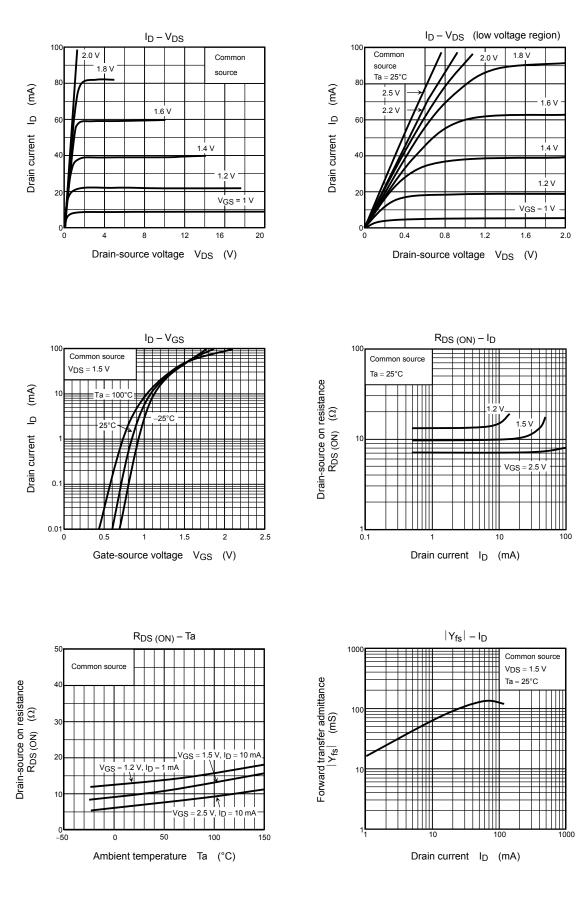
## (a) Test circuit



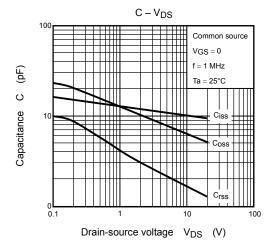


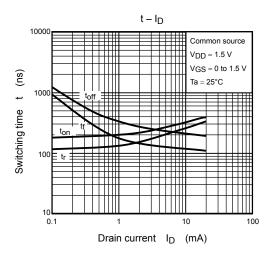


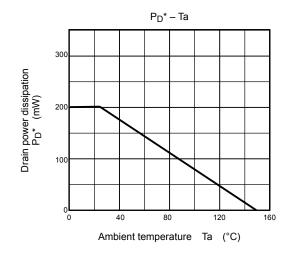
(Q1, Q2 common)



(Q1, Q2 common)







\*: TOTAL rating

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20070701-EN GENERAL

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